

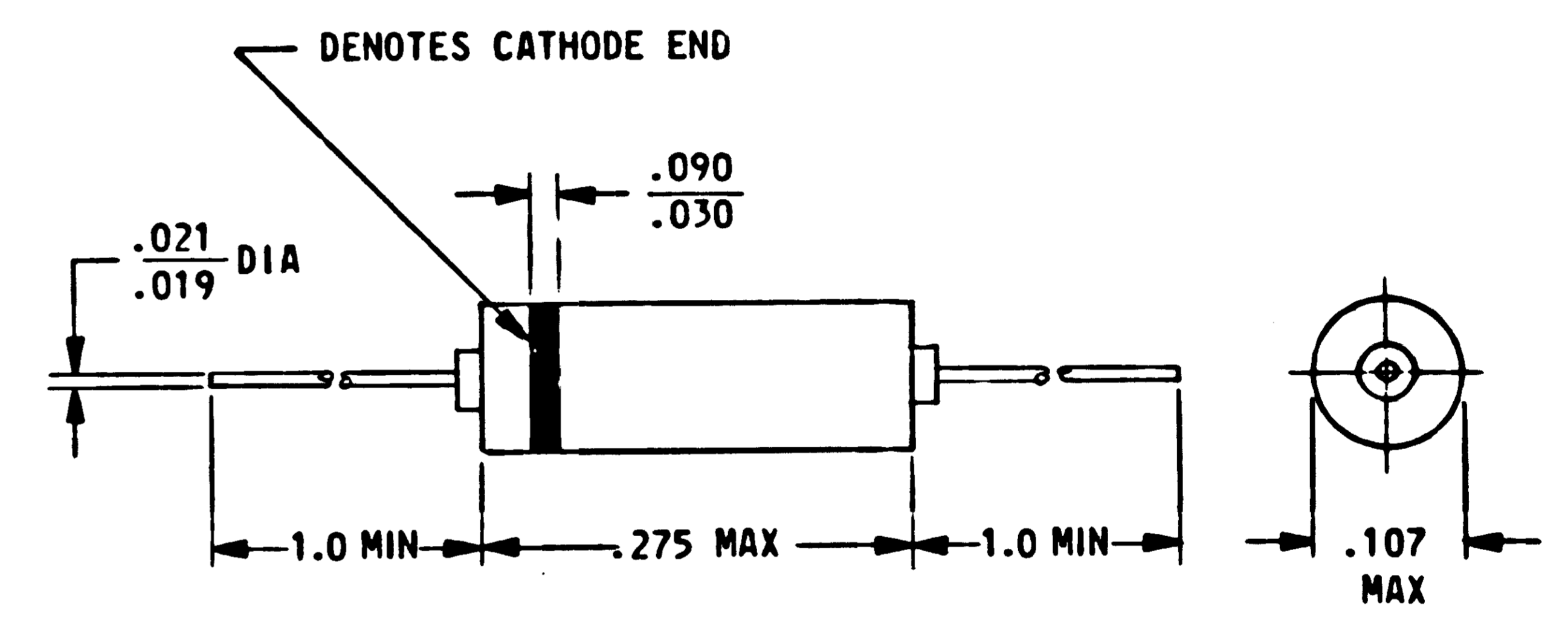
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1929001		REVISIONS		
SYM	DESCRIPTION	DATE	APPROVAL	
A	ADDED PROCUREMENT NOTE 3 PER TDRR	00433 2-20-62	WIK	

NOTES:

1. REQUIREMENTS:
 - A. ENCAPSULATION: GLASS. UNITS SHALL BE HERMETICALLY SEALED.
 - B. LEAD MATERIAL SHALL BE IRON-NICKEL ALLOY, COPPER CLAD, GOLD PLATED IN ACCORDANCE WITH NASA DOCUMENT PS 1015401. A CERTIFICATE OF COMPLIANCE WITH THIS REQUIREMENT SHALL ACCOMPANY EACH SHIPMENT.
 - C. SHALL WITHSTAND A THERMAL SHOCK OF 300°C FROM 0°C WITHIN 30 SECONDS AND BE RETURNED TO ROOM AMBIENT WITHOUT AFFECTING OPERATING CHARACTERISTICS AS SPECIFIED HEREIN, IN ADDITION TO THE REQUIREMENTS OF ND 1002000.
 - D. SUPPLIER SHALL CONFORM TO THE QUALITY ASSURANCE PROVISIONS OF NASA DOCUMENT 1015404 SECTION II.
 - E. UNITS SHALL BE 100 PERCENT INSPECTED FOR COMPLIANCE WITH THE REQUIREMENTS IN TABLE I UNLESS OTHERWISE SPECIFIED.
 - F. TRANSIENT RESPONSE: USING A TECHTRONIX TYPE S PLUG-IN UNIT AND $I_F = 5$ MILLIAMPERES AND $I_R = 100$ MICROAMPERES, THE MEASURED TIME MUST BE LESS THAN .5 MICROSECOND. THE SLOPE OF THAT PORTION OF THE DISCHARGE CURVE CORRESPONDING TO LINEAR CAPACITANCE SHALL BE GREATER THAN .5 VOLTS AND .2 MICROSECOND.
 - G. LEAD TESTS: EACH LEAD SHALL BE CAPABLE OF WITHSTANDING THE FOLLOWING TESTS:
 - (1) LEAD BEND TEST: WITH THE COMPONENT BODY HELD IN A VERTICAL POSITION AND A ONE POUND WEIGHT SUSPENDED IN AN AXIAL DIRECTION FROM THE LEAD UNDER TEST, 2 CYCLES OF BENDS SHALL BE ACCOMPLISHED. ONE CYCLE OF BENDS SHALL CONSIST OF MOVING THE BODY OF THE UNIT IN THE SAME PLANE THROUGH 90 DEGREES IN ONE DIRECTION THEN BACK 180 DEGREES IN THE OPPOSITE DIRECTION AND BACK 90 DEGREES TO THE ORIGINAL POSITION. NO MECHANICAL DAMAGE OR LACK OF PERFORMANCE SHALL BE EVIDENCED AFTER THE TEST.
 - (2) LEAD PULL TEST: EACH LEAD SHALL WITHSTAND AN AXIAL PULL OF 4 POUNDS MINIMUM. NO MECHANICAL DAMAGE OR LACK OF PERFORMANCE SHALL BE EVIDENCED AFTER THE TEST.
 - H. EACH DIODE SHALL BE MICROSCOPICALLY INSPECTED, BEFORE PAINTING, UNDER 10X MAGNIFICATION, FOR FOREIGN PARTICLES, TIPPED DICE, INCOMPLETE SEALING, AND REDUCTION OF LEAD DIAMETER AT POINT OF FUSING.
 - I. PREPARATION FOR DELIVERY: IN ACCORDANCE WITH MIL-S-19491 LEVEL C PRESERVATION AND PACKAGING AND LEVEL C PACKING. MARKING OF UNIT PACKAGES AND EXTERIOR SHIPPING CONTAINERS SHALL INCLUDE THE NASA DRAWING NUMBER AND REVISION LETTER.

FOR INFORMATION ONLY
 CLASS B RELEASE TDR No. 00165 DATE 12-12-62



2. INTERPRET DRAWING IN ACCORDANCE WITH STANDARDS PRESCRIBED BY MIL-D-70327.
3. A. WAIVE AS REQUIRED ALL INFORMATION PRESENTED ON THIS DRAWING EXCEPT LEAD MATERIAL SPEC. & PHYSICAL DIMENSIONS.
- B. UPON SPECIFIC INSTRUCTION BY (TD) TECHNICAL DIRECTIVE PROCURE THIS PART AS CHANGE LETTER A BY ORDERING TO VENDOR CATALOG NO. & SPECIFICATIONS. REFERENCE ND 1002034.
- C. DISREGARD THIS NOTE IN ITS ENTIRETY IF REFERENCE IS MADE TO THIS DRAWING BY OTHER THAN REVISION LETTER A.

PROCURE ONLY FROM APPROVED SOURCES LISTED ON ND1002034 FOR THIS DRAWING

REV— A	REV—
SHEET 1	SHEET 2
REVISION STATUS OF SHEETS	

UNLESS OTHERWISE SPECIFIED DIMENSIONS ARE IN INCHES	
TOLERANCES ON	
FRACTIONS DECIMALS ANGLES	
± ± ±	
DO NOT SCALE THIS DRAWING	
MATERIAL	
SEE NOTE 1	
HEAT TREATMENT	
NONE	
FINAL FINISH	
NONE	
NEXT ASSY	USED ON
APPLICATION	

QTY REQD	PART OR IDENTIFYING NO.	NOMENCLATURE OR DESCRIPTION	FIND NO.
LIST OF MATERIALS			
MIT INSTRUMENTATION LAB CAMBRIDGE, MASS.		MANNED SPACECRAFT CENTER HOUSTON, TEXAS	
DRAWN <i>Ray Wheeler</i> DATE 2/9/62		SEMICONDUCTOR DEVICE, DIODE	
CHECKED <i>H. M. ...</i> 27 Nov 62			
APPROVAL <i>E. C. Hall</i> 11 Dec 62		SPECIFICATION CONTROL DRAWING	
APPROVAL			
NASA APPROVAL <i>W. J. ...</i> 12-12-62		CODE IDENT NO.	SIZE
MIT APPROVAL <i>W. J. ...</i> 12/12/62			C
SCALE NONE		WT	NASA DRAWING NO. 1006751
			SHEET 1 OF 2

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